

Search Notes

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Leith A. Al-Nazer

Applicant(s)/Patent under
Reexamination

IDE ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
349	149-152	9/27/2005	LA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST prior art text search (see "Examiner Search Notes")	9/27/2005	LA